

PCN Number:	20190219000.0	PCN Date:	February 19, 2019
Title:	Datasheet for TPS65916		
Customer Contact:	PCN Manager	Dept:	Quality Services
Change Type:			
<input type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Design
<input type="checkbox"/>	Assembly Process	<input checked="" type="checkbox"/>	Data Sheet
<input type="checkbox"/>	Assembly Materials	<input type="checkbox"/>	Part number change
<input type="checkbox"/>	Mechanical Specification	<input type="checkbox"/>	Test Site
<input type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Bump Site
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Bump Material
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Bump Process
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Site
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Materials
<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Process

Notification Details

Description of Change:

Texas Instruments Incorporated is announcing an information only notification. The product datasheet(s) is being updated as summarized below. The following change history provides further details.



TPS65916

SLVSD09C – MARCH 2016 – REVISED FEBRUARY 2019

Changes from Revision B (March 2017) to Revision C	Page
• Added footnote recommending not to pull open-drain GPIOs up to an always-on voltage domain	9
• Clarified that LDO1 and LDO2 input pins are not included in this minimum recommended operating voltage. See <i>Electrical Characteristics: LDO Regulators</i> for more information.	12
• Added LDO and SMPS output capacitance footnote	13
• Added SMPS Output voltage slew rate description	15
• Changed the comparison condition from VCCA to VCC_SENSE in the <i>Embedded Power Controller</i> section.....	32
• Added typical debounce time from POWERHOLD to the enable of the first rail in the power sequence.	33
• Changed discharge resistance to match electrical characteristics table	42
• Changed description of clock dithering from internal to external only	44
• Added information about shutdown timing during short circuit detection	45
• Updated POWERGOOD block diagram and description to clarify dual phase operation.	46
• Added notes to the <i>SMPS Controls for DVS</i> image	48
• Added the equation to convert GPADC code to internal die temperature in the <i>12-Bit Sigma-Delta General-Purpose ADC (GPADC)</i> section.....	52
• Additional description of VSYS_LO functionality	66
• Added details on identifying device version.	69
• SMPS and LDO output capacitance specification further explained	74
• Added design considerations for VCCA capacitance to support loss of power.....	74
• Corrected 9-Vpp with TV absolute maximum specification in the <i>Layout Guidelines</i> section.....	79
• Updated requirements relating to measurement of high-side and low-side FETs in the <i>Layout Guidelines</i> section...	80
• Updated images and description on differential measurements across high-side and low-side FETs	81

The datasheet number will be changing.

Device Family	Change From:	Change To:
TPS65916	SLVSD09B	SLVSD09C

These changes may be reviewed at the datasheet links provided.

<http://www.ti.com/product/TPS65916>

Reason for Change:

To accurately reflect device characteristics.

Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.

Changes to product identification resulting from this PCN:

None.

Product Affected:

TPS659161RGZR	TPS659162RGZR	TPS659162RGZT	TPS659163RGZR
TPS659163RGZT			

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

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